

**Notice of References Cited**

Application/Control No.

10/720,110

Applicant(s)/Patent Under

Reexamination

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,064,756	05-2000	Beaty et al.	382/146
*	B	US-7,027,963	04-2006	Watanabe et al.	703/1
*	C	US-6,173,070	01-2001	Michael et al.	382/145
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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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